

# INVITATION TO EXHIBIT

## 66th ARFTG CONFERENCE Washington, D.C. December 1st-2nd, 2005

The Automatic RF Techniques Group will hold its 66th ARFTG Microwave Measurement Conference at the Marriott Hotel in Washington, D.C. The two-day conference technical theme is “*Measurements of High Performance Devices and Applications*” and will also cover all aspects of microwave measurement.

During this conference there will be an exhibits area for the display of microwave measurement equipment, simulation tools, and associated products. On behalf of the Exhibits Committee I would like to extend an invitation to exhibit. This is an excellent opportunity to present your company’s latest products and techniques to an exceptionally qualified audience.

The exhibits area will be adjacent to the technical program hall, which will ensure exposure to all of the conference participants. This is a valuable opportunity to exhibit your products to a focused measurement community in the comfortable, personal atmosphere afforded by ARFTG.

The exhibitor application and rules document is attached. Please contact me if you have any questions about this opportunity. I hope that you will join us in Washington, D.C.!

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